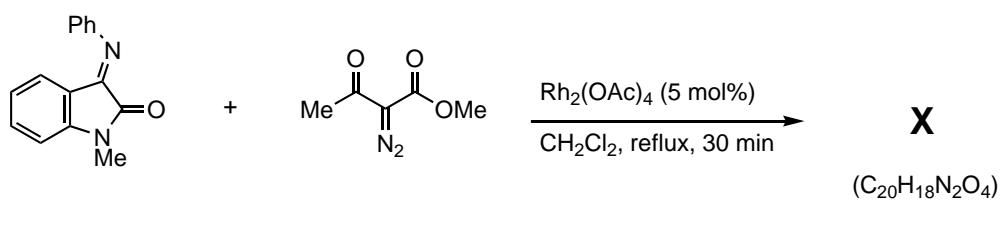
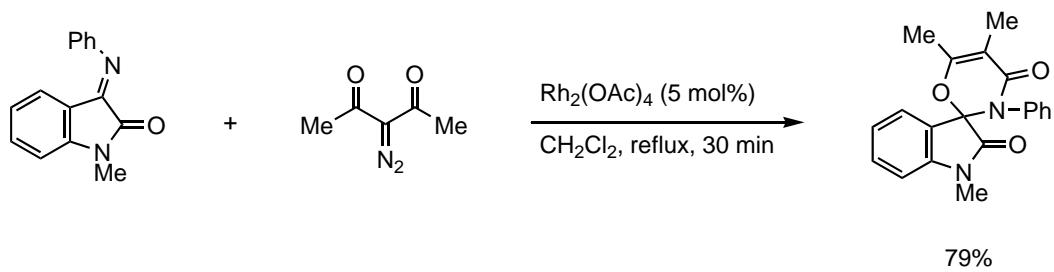


J. Suffert *et al.* *ACIE*, **2012**, early view

DOI: 10.1002/anie.201107934



B.V. S. Reddy *et al.* *Tetrahedron Lett.* **2012**, 53, 2396